

## Application/Control No. Applicant(s)/Patent under Reexamination MEAD ET AL. Examiner Art Unit TUAN C. TO 3663

	SEARCHED				
Class	Subclass	Date	Examiner		
342	104	5/9/2008	/πι		
342	109	59/2008	лτι		
342	107	5/9/2008	/TT/		
701	301	5/9/2008	/ПΙ		
701	96	5/9/2008	/TT/		
340	902	5/9/2008	/TT/		
340	465	5/9/2008	/ПΤ/		
340	466	5/9/2008	/П		
340	988	5/9/2008	/ПΙ		
340	425.5	5/9/2008	лти		
340	435	5/9/2008	лти		
340	436	5/9/2008	/TT/		
180	170	5/9/2008	/ПΙ		
180	282	5/9/2008	лти		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
342	104	5/9/2008	/TT/	
342	107	5/9/2008	/TT/	
342	109	5/9/2008	/11/	
701/301		5/9/2008	лті	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
TEXT SEARCH UPDATED	5/9/2008	лт		